

# RF Power LDMOS Transistor

## N-Channel Enhancement-Mode Lateral MOSFET

Designed for Class A or Class AB power amplifier applications with frequencies up to 2000 MHz. Suitable for analog and digital modulation and multicarrier amplifier applications.

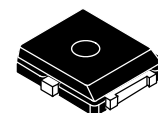
- Typical Two-Tone Performance @ 1960 MHz, 28 Vdc,  $I_{DQ} = 50$  mA,  
 $P_{out} = 4$  W PEP  
 Power Gain — 18 dB  
 Drain Efficiency — 33%  
 IMD — -34 dBc
- Typical Two-Tone Performance @ 900 MHz, 28 Vdc,  $I_{DQ} = 50$  mA,  
 $P_{out} = 4$  W PEP  
 Power Gain — 19 dB  
 Drain Efficiency — 33%  
 IMD — -39 dBc
- Capable of Handling 5:1 VSWR @ 28 Vdc, 1960 MHz, 4 W CW Output Power

### Features

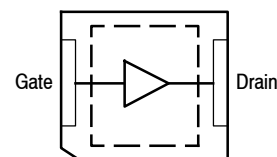
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- On-Chip RF Feedback for Broadband Stability
- Integrated ESD Protection
- In Tape and Reel. T1 Suffix = 1,000 Units, 16 mm Tape Width, 7-inch Reel.

**MMRF1014NT1**

**1-2000 MHz, 4 W, 28 V  
 CLASS A/AB  
 RF POWER MOSFET**



**PLD-1.5  
 PLASTIC**



Note: The center pad on the backside of the package is the source terminal for the transistor.

**Figure 1. Pin Connections**

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-0.5, +68	Vdc
Gate-Source Voltage	$V_{GS}$	-0.5, +12	Vdc
Storage Temperature Range	$T_{stg}$	-65 to +150	°C
Operating Junction Temperature	$T_J$	150	°C

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value (1,2)	Unit
Thermal Resistance, Junction to Case Case Temperature 76°C, 4 W PEP, Two-Tone Case Temperature 79°C, 4 W CW	$R_{\theta JC}$	8.8 8.5	°C/W

**Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	1C
Machine Model (per EIA/JESD22-A115)	A
Charge Device Model (per JESD22-C101)	IV

1. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

**Table 4. Moisture Sensitivity Level**

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

**Table 5. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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**Off Characteristics**

Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 68\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{Adc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 28\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{Adc}$
Gate-Source Leakage Current ( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )	$I_{GSS}$	—	—	500	$\text{nAdc}$

**On Characteristics**

Gate Threshold Voltage ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 50\text{ mAdc}$ )	$V_{GS(th)}$	1.2	2	2.7	Vdc
Gate Quiescent Voltage ( $V_{DS} = 28\text{ Vdc}$ , $I_D = 50\text{ mAdc}$ )	$V_{GS(Q)}$	—	2.7	—	Vdc
Fixture Gate Quiescent Voltage <sup>(1)</sup> ( $V_{DD} = 28\text{ Vdc}$ , $I_D = 50\text{ mAdc}$ , Measured in Functional Test)	$V_{GG(Q)}$	2.2	3	4.2	Vdc
Drain-Source On-Voltage ( $V_{GS} = 10\text{ Vdc}$ , $I_D = 50\text{ mAdc}$ )	$V_{DS(on)}$	—	0.27	0.37	Vdc

**Dynamic Characteristics**

Reverse Transfer Capacitance ( $V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{rss}$	—	21	—	pF
Output Capacitance ( $V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{oss}$	—	25	—	pF
Input Capacitance ( $V_{DS} = 28\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz)	$C_{iss}$	—	30	—	pF

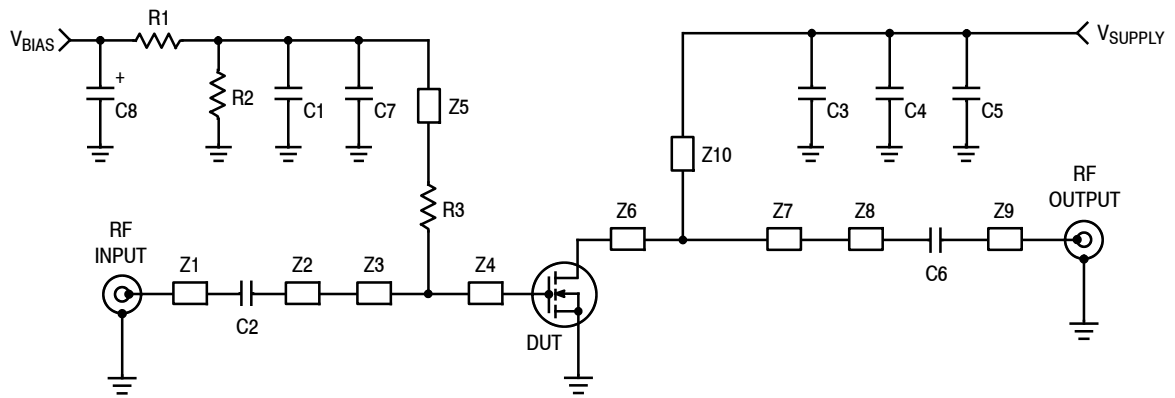
**Functional Tests** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ} = 50\text{ mA}$ ,  $P_{out} = 4\text{ W PEP}$ ,  $f_1 = 1960\text{ MHz}$ ,  $f_2 = 1960.1\text{ MHz}$ , Two-Tone Test

Power Gain	$G_{ps}$	16.5	18	20	dB
Drain Efficiency	$\eta_D$	28	33	—	%
Intermodulation Distortion	IMD	—	-34	-28	dBc
Input Return Loss	IRL	—	-12	-10	dB

**Typical Performance** (In Freescale 900 MHz Demo Board, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ} = 50\text{ mA}$ ,  $P_{out} = 4\text{ W PEP}$ ,  $f = 900\text{ MHz}$ , Two-Tone Test, 100 kHz Tone Spacing

Power Gain	$G_{ps}$	—	19	—	dB
Drain Efficiency	$\eta_D$	—	33	—	%
Intermodulation Distortion	IMD	—	-39	—	dBc
Input Return Loss	IRL	—	-12	—	dB

1.  $V_{GG} = \frac{11}{10} \times V_{GS(Q)}$ . Parameter measured on Freescale Test Fixture, due to resistive divider network on the board. Refer to Test Circuit Schematic.



Z1	0.054" x 0.430" Microstrip	Z7	0.210" x 1.220" Microstrip
Z2	0.054" x 0.137" Microstrip	Z8	0.054" x 0.680" Microstrip
Z3	0.580" x 0.420" Microstrip	Z9	0.054" x 0.260" Microstrip
Z4	0.580" x 0.100" Microstrip	Z10	0.025" x 0.930" Microstrip
Z5	0.025" x 0.680" Microstrip	PCB	Arlon CuClad 250GX-0300-55-22, 0.020", $\epsilon_r = 2.5$
Z6	0.210" x 0.100" Microstrip		

**Figure 2. MMRF1014NT1 Test Circuit Schematic**

**Table 6. MMRF1014NT1 Test Circuit Component Designations and Values**

Part	Description	Part Number	Manufacturer
C1	100 nF Chip Capacitor	CDR33BX104AKYS	Kemet
C2, C3, C6, C7	9.1 pF Chip Capacitors	ATC100B9R1CT500XT	ATC
C4, C5	10 $\mu$ F, 50 V Chip Capacitors	GRM55DR61H106KA88B	Murata
C8	10 $\mu$ F, 35 V Tantalum Chip Capacitor	T490D106K035AT	Kemet
R1	1 k $\Omega$ , 1/4 W Chip Resistor	CRCW12061001FKEA	Vishay
R2	10 k $\Omega$ , 1/4 W Chip Resistor	CRCW12061002FKEA	Vishay
R3	10 $\Omega$ , 1/4 W Chip Resistor	CRCW120610R0FKEA	Vishay

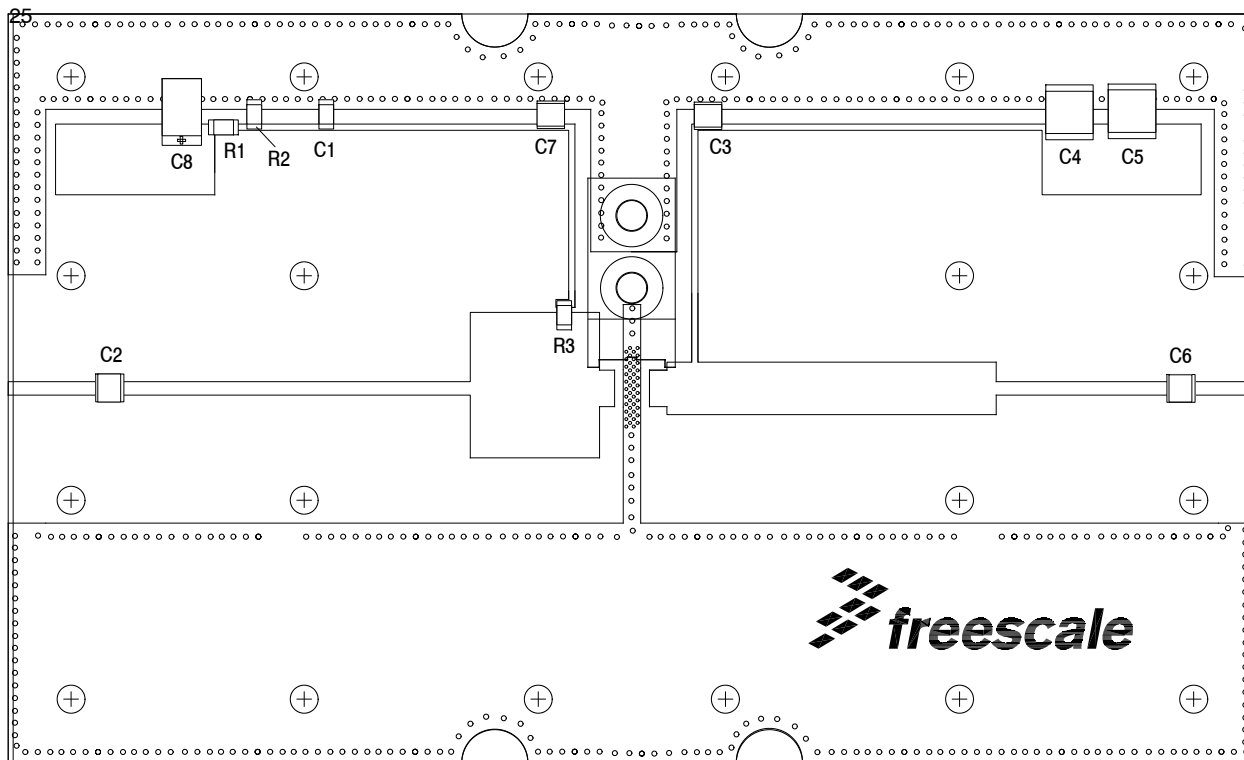
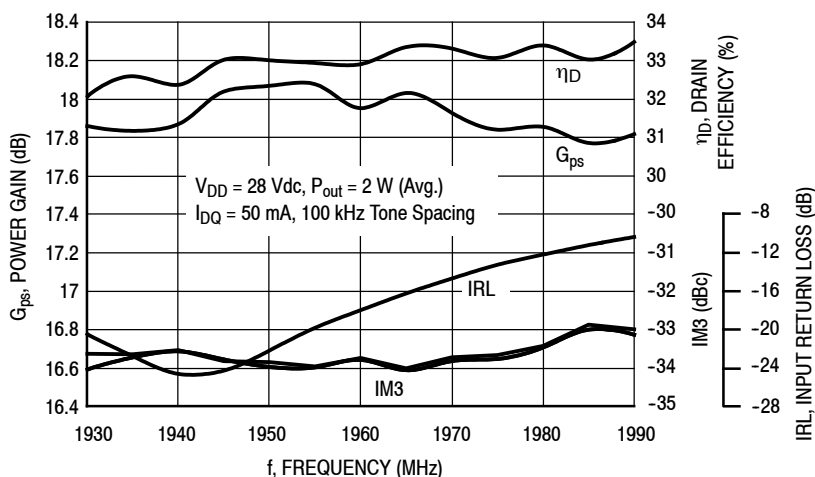
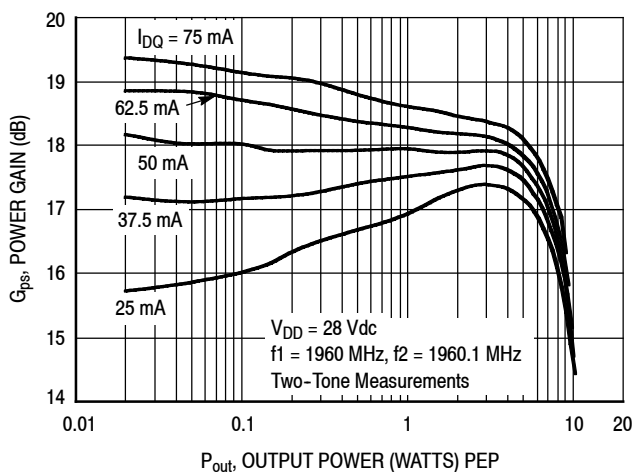


Figure 3. MMRF1014NT1 Test Circuit Component Layout

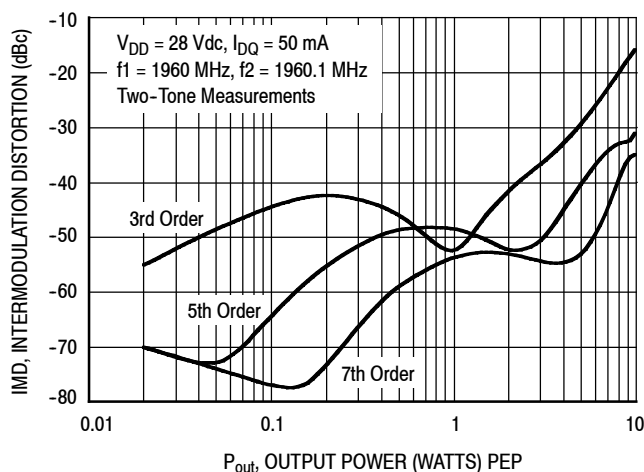
### TYPICAL CHARACTERISTICS



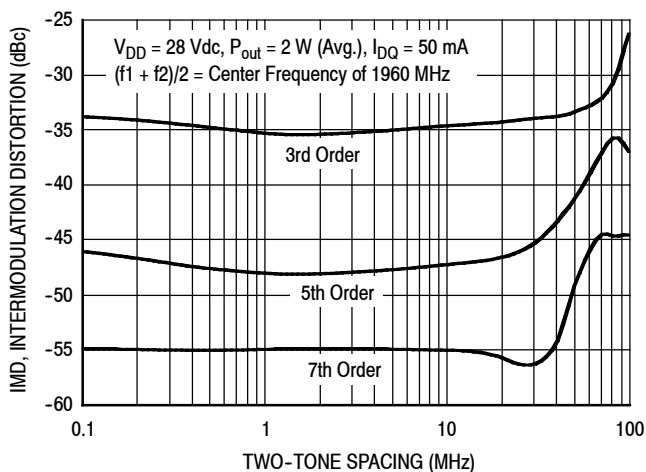
**Figure 4. Two-Tone Wideband Performance @ P<sub>out</sub> = 2 Watts Avg.**



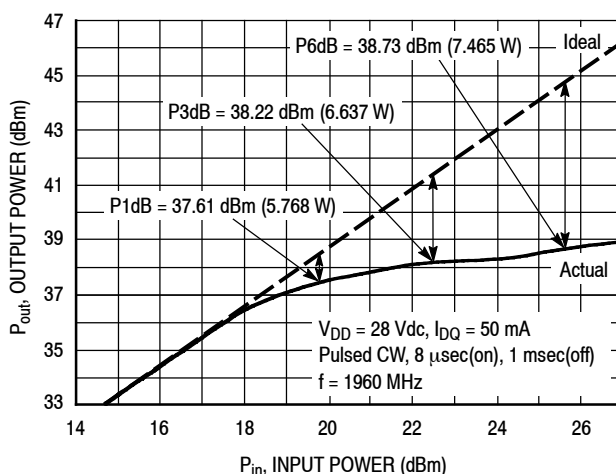
**Figure 5. Two-Tone Power Gain versus Output Power**



**Figure 6. Intermodulation Distortion Products versus Output Power**

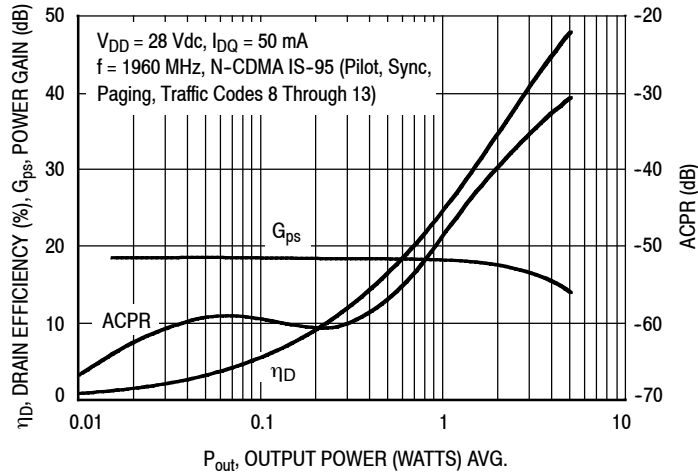


**Figure 7. Intermodulation Distortion Products versus Tone Spacing**

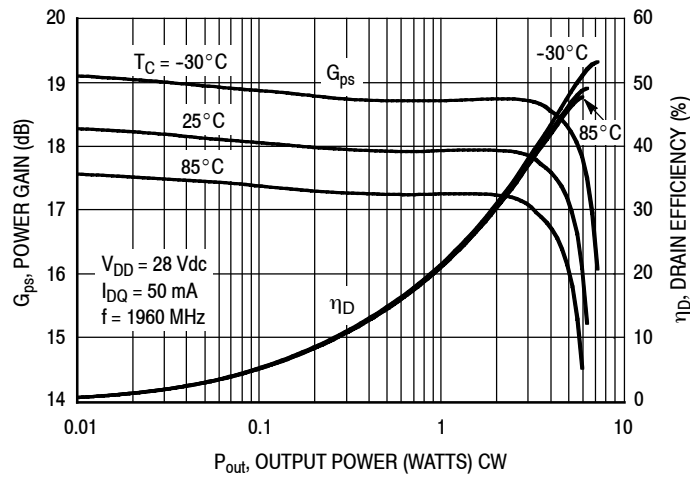


**Figure 8. Pulsed CW Output Power versus Input Power**

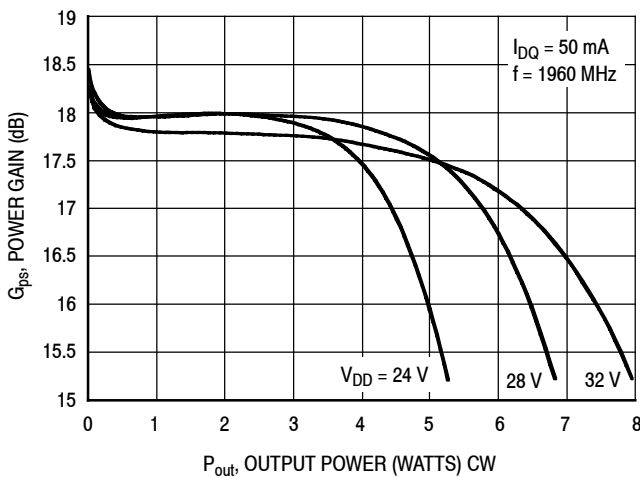
## TYPICAL CHARACTERISTICS



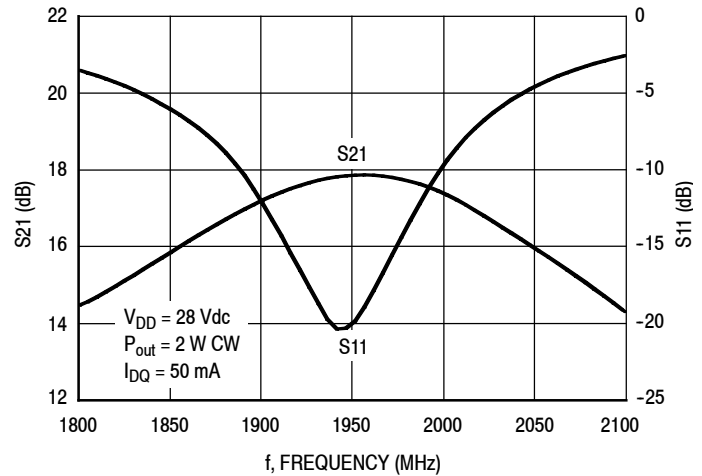
**Figure 9. Single-Carrier CDMA ACPR, Power Gain and Drain Efficiency versus Output Power**



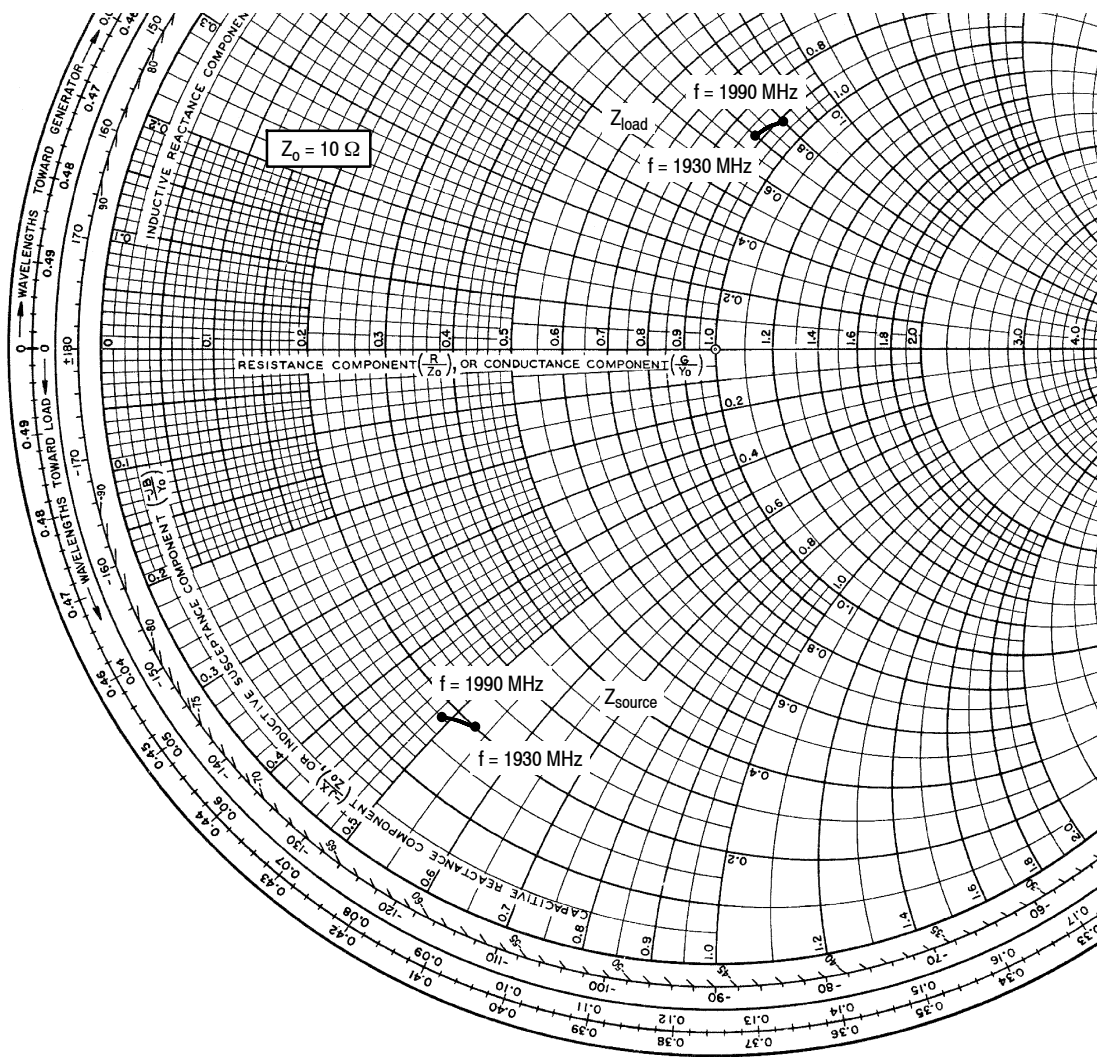
**Figure 10. Power Gain and Drain Efficiency versus CW Output Power**



**Figure 11. Power Gain versus Output Power**



**Figure 12. Broadband Frequency Response**



$V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ} = 50 \text{ mA}$ ,  $P_{out} = 4 \text{ W PEP}$

f MHz	$Z_{source}$ $\Omega$	$Z_{load}$ $\Omega$
1930	$1.96 - j5.34$	$8.78 + j6.96$
1960	$1.89 - j5.10$	$8.93 + j7.46$
1990	$1.82 - j4.85$	$9.11 + j7.97$

$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

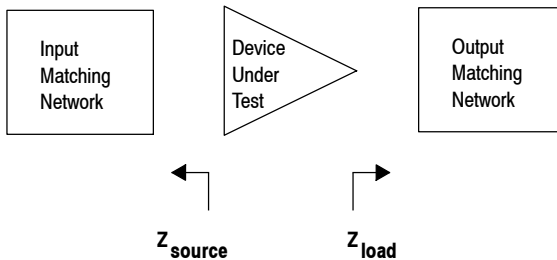


Figure 13. Series Equivalent Source and Load Impedance

**Table 7. Common Source S-Parameters** ( $V_{DD} = 28$  Vdc,  $I_{DQ} = 50$  mA,  $T_A = 25^\circ\text{C}$ , 50 Ohm System)

f MHz	S <sub>11</sub>		S <sub>21</sub>		S <sub>12</sub>		S <sub>22</sub>	
	S <sub>11</sub>	∠ φ	S <sub>21</sub>	∠ φ	S <sub>12</sub>	∠ φ	S <sub>22</sub>	∠ φ
500	0.649	-116.340	7.902	105.420	0.056	-73.750	0.548	-33.570
550	0.695	-121.680	7.502	98.790	0.053	-80.570	0.593	-41.480
600	0.733	-126.560	7.111	92.380	0.049	-87.010	0.632	-48.890
650	0.770	-131.340	6.699	86.290	0.045	-93.280	0.669	-56.000
700	0.800	-135.740	6.302	80.450	0.041	-99.120	0.701	-62.810
750	0.827	-140.030	5.922	74.850	0.038	-104.850	0.727	-69.290
800	0.848	-143.950	5.552	69.630	0.035	-110.110	0.750	-75.350
850	0.866	-147.690	5.220	64.580	0.032	-115.220	0.770	-81.130
900	0.882	-151.140	4.891	59.970	0.029	-119.960	0.786	-86.570
950	0.895	-154.560	4.597	55.490	0.026	-124.790	0.800	-91.730
1000	0.907	-157.590	4.315	51.240	0.024	-129.090	0.813	-96.660
1050	0.916	-160.540	4.060	47.170	0.022	-133.370	0.824	-101.340
1100	0.923	-163.310	3.819	43.340	0.020	-137.460	0.833	-105.790
1150	0.929	-165.930	3.601	39.650	0.018	-141.440	0.840	-110.050
1200	0.935	-168.430	3.398	36.110	0.017	-145.330	0.847	-114.170
1250	0.938	-170.770	3.210	32.740	0.015	-149.540	0.851	-118.060
1300	0.942	-173.030	3.036	29.490	0.014	-153.430	0.856	-121.880
1350	0.945	-175.140	2.875	26.360	0.013	-157.460	0.859	-125.520
1400	0.948	-177.170	2.728	23.330	0.012	-161.910	0.863	-129.020
1450	0.951	-179.090	2.590	20.440	0.011	-166.180	0.866	-132.390
1500	0.953	179.030	2.464	17.640	0.010	-170.630	0.869	-135.650
1550	0.954	177.270	2.347	14.920	0.009	-174.890	0.872	-138.760
1600	0.955	175.570	2.240	12.320	0.008	179.950	0.875	-141.750
1650	0.956	173.980	2.139	9.740	0.008	173.920	0.877	-144.650
1700	0.957	172.350	2.047	7.250	0.007	167.710	0.880	-147.480
1750	0.957	170.800	1.958	4.810	0.007	161.810	0.882	-150.180
1800	0.958	169.340	1.879	2.440	0.006	155.370	0.884	-152.760
1850	0.959	167.920	1.806	0.260	0.006	148.940	0.886	-155.230
1900	0.959	166.510	1.736	-1.980	0.005	142.630	0.887	-157.580
1950	0.960	165.200	1.668	-4.310	0.005	136.740	0.888	-160.050
2000	0.959	163.800	1.611	-6.240	0.005	129.910	0.890	-162.070
2050	0.959	162.420	1.555	-8.290	0.005	123.810	0.891	-164.190
2100	0.958	161.170	1.504	-10.270	0.005	118.200	0.892	-166.140
2150	0.958	159.840	1.456	-12.210	0.005	112.740	0.893	-168.060
2200	0.957	158.560	1.412	-14.130	0.005	108.460	0.894	-169.840
2250	0.957	157.160	1.372	-16.010	0.005	103.840	0.896	-171.610
2300	0.955	155.870	1.334	-17.870	0.005	99.310	0.896	-173.260
2350	0.954	154.510	1.300	-19.700	0.005	95.360	0.897	-174.830
2400	0.953	153.120	1.268	-21.510	0.005	91.030	0.898	-176.390
2450	0.953	151.730	1.238	-23.250	0.005	87.460	0.899	-177.840

(continued)



**Table 7. Common Source S-Parameters** ( $V_{DD} = 28$  Vdc,  $I_{DQ} = 50$  mA,  $T_A = 25^\circ\text{C}$ , 50 Ohm System) (continued)

f MHz	S <sub>11</sub>		S <sub>21</sub>		S <sub>12</sub>		S <sub>22</sub>	
	S <sub>11</sub>	$\angle \phi$	S <sub>21</sub>	$\angle \phi$	S <sub>12</sub>	$\angle \phi$	S <sub>22</sub>	$\angle \phi$
2500	0.952	150.340	1.211	-25.120	0.006	84.160	0.899	-179.270
2550	0.950	149.010	1.187	-26.920	0.006	80.780	0.897	179.420
2600	0.949	147.380	1.166	-28.650	0.006	77.880	0.897	178.120
2650	0.948	145.920	1.144	-30.420	0.007	74.670	0.898	176.840
2700	0.944	144.200	1.121	-32.310	0.007	71.360	0.896	175.480
2750	0.944	142.790	1.105	-34.230	0.007	67.980	0.897	174.060
2800	0.943	141.020	1.088	-36.000	0.007	63.950	0.897	172.930
2850	0.941	139.410	1.073	-37.870	0.007	61.230	0.896	171.630
2900	0.940	137.640	1.058	-39.760	0.008	59.810	0.896	170.330
2950	0.938	135.900	1.045	-41.680	0.008	58.280	0.896	169.040
3000	0.937	133.860	1.032	-43.610	0.008	56.740	0.895	167.510

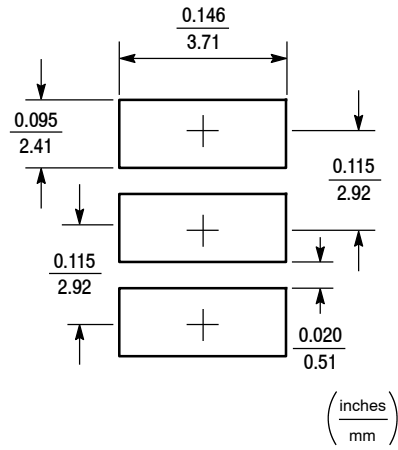


Figure 14. Solder Footprint for PLD-1.5

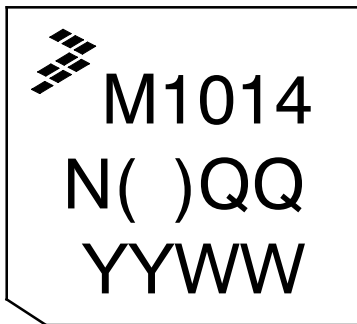
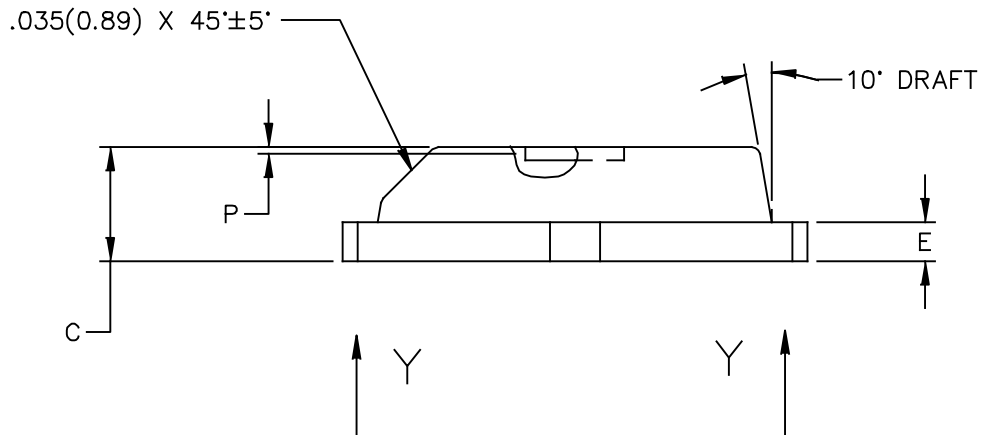
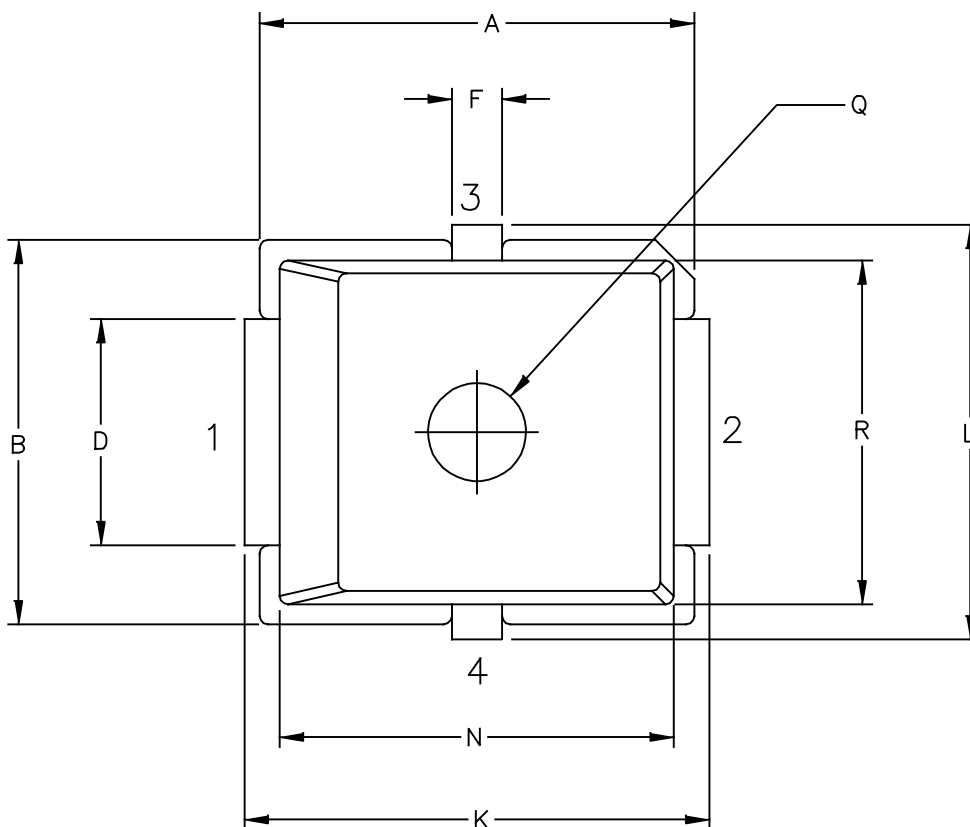
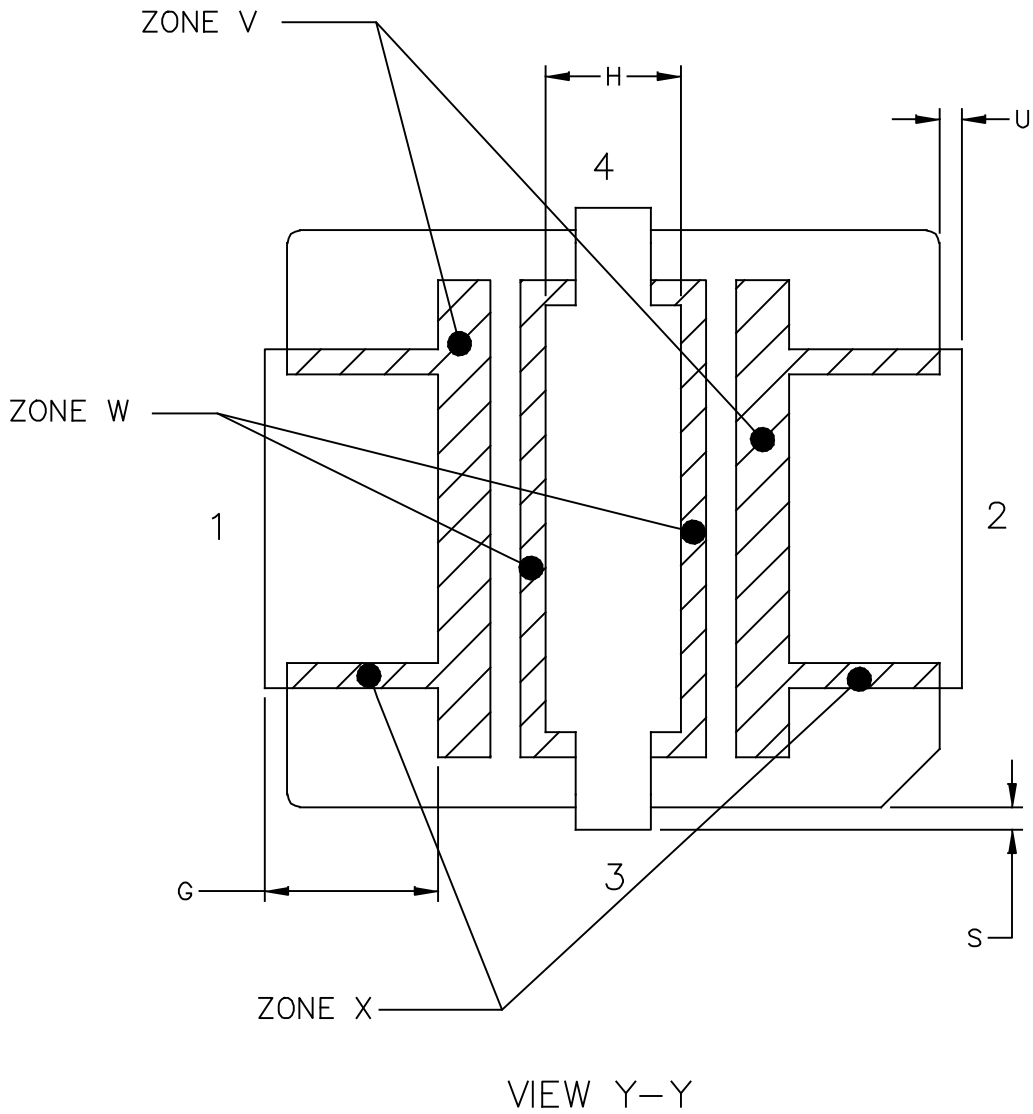


Figure 15. Product Marking

**PACKAGE DIMENSIONS**



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TITLE:  PLD-1.5	DOCUMENT NO: 98ASB15740C	REV: D	
	CASE NUMBER: 466-03	31 MAR 2005	
	STANDARD: NON-JEDEC		



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TITLE:  PLD-1.5		DOCUMENT NO: 98ASB15740C		REV: D	
		CASE NUMBER: 466-03		31 MAR 2005	
		STANDARD: NON-JEDEC			

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. RESIN BLEED/FLASH ALLOWABLE IN ZONES V, W AND X.

STYLE 1:

- PIN 1 - DRAIN
- PIN 2 - GATE
- PIN 3 - SOURCE
- PIN 4 - SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	.255	.265	6.48	6.73	Q	.055	.063	1.40	1.60
B	.225	.235	5.72	5.97	R	.200	.210	5.08	5.33
C	.065	.072	1.65	1.83	S	.006	.012	0.15	0.31
D	.130	.150	3.30	3.81	U	.006	.012	0.15	0.31
E	.021	.026	0.53	0.66	ZONE V	.000	.021	0.00	0.53
F	.026	.044	0.66	1.12	ZONE W	.000	.010	0.00	0.25
G	.050	.070	1.27	1.78	ZONE X	.000	.010	0.00	0.25
H	.045	.063	1.14	1.60					
J	.160	.180	4.06	4.57					
K	.273	.285	6.93	7.24					
L	.245	.255	6.22	6.48					
N	.230	.240	5.84	6.10					
P	.000	.008	0.00	0.20					
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TITLE:  PLD-1.5					DOCUMENT NO: 98ASB15740C			REV: D	
					CASE NUMBER: 466-03			31 MAR 2005	
					STANDARD: NON-JEDEC				

## PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following resources to aid your design process.

### Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### Software

- Electromigration MTTF Calculator

For Software, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

## REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	July 2014	• Initial Release of Data Sheet

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Компания «Life Electronics» занимается поставками электронных компонентов импортного и отечественного производства от производителей и со складов крупных дистрибьюторов Европы, Америки и Азии.

С конца 2013 года компания активно расширяет линейку поставок компонентов по направлению коаксиальный кабель, кварцевые генераторы и конденсаторы (керамические, пленочные, электролитические), за счёт заключения дистрибьюторских договоров

Мы предлагаем:

- Конкурентоспособные цены и скидки постоянным клиентам.
- Специальные условия для постоянных клиентов.
- Подбор аналогов.
- Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.
- Приемлемые сроки поставки, возможна ускоренная поставка.
- Доставку товара в любую точку России и стран СНГ.
- Комплексную поставку.
- Работу по проектам и поставку образцов.
- Формирование склада под заказчика.
- Сертификаты соответствия на поставляемую продукцию (по желанию клиента).
- Тестирование поставляемой продукции.
- Поставку компонентов, требующих военную и космическую приемку.
- Входной контроль качества.
- Наличие сертификата ISO.

В составе нашей компании организован Конструкторский отдел, призванный помогать разработчикам, и инженерам.

Конструкторский отдел помогает осуществить:

- Регистрацию проекта у производителя компонентов.
- Техническую поддержку проекта.
- Защиту от снятия компонента с производства.
- Оценку стоимости проекта по компонентам.
- Изготовление тестовой платы монтаж и пусконаладочные работы.



Тел: +7 (812) 336 43 04 (многоканальный)

Email: [org@lifeelectronics.ru](mailto:org@lifeelectronics.ru)